



U74HC4049

CMOS IC

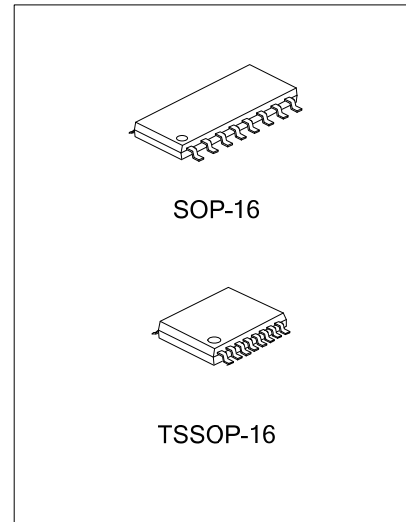
HEX INVERTING HIGH-TO-LOW LEVEL SHIFTER

DESCRIPTION

The **U74HC4049** is a high speed Si-gate CMOS device which contains six independent inverters and they perform the function $Y = \overline{A}$.

On the input circuit of this device has a modified input protection structure which has no diode connected to V_{CC} . Input voltages of up to 15-V may therefore be used.

This feature enables the inverters to be used as logic level translators, which will convert high level logic to low level logic, while operating from a low voltage power supply. For example 15-V logic can be converted down to 2-V logic. At the same time each part can be used as a simple inverter without level translation.



FEATURES

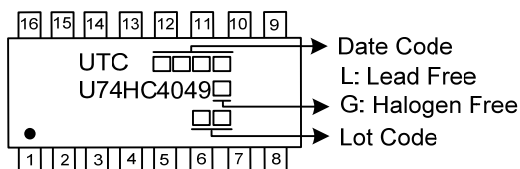
- * Inputs accept voltages to 15V
- * Low power dissipation
- * Enable to be used as a logic level translator

ORDERING INFORMATION

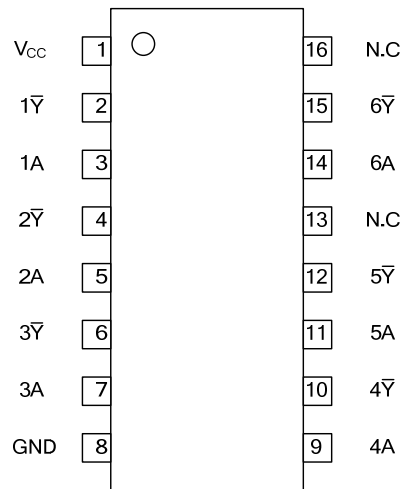
Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74HC4049L-S16-R	U74HC4049G-S16-R	SOP-16	Tape Reel
U74HC4049L-P16-R	U74HC4049G-P16-R	TSSOP-16	Tape Reel

<p>U74HC4049G-S16-R</p> <ul style="list-style-type: none"> (1) Packing Type (2) Package Type (3) Green Package 	<ul style="list-style-type: none"> (1) R: Tape Reel (2) S16: SOP-16, P16: TSSOP-16 (3) G: Halogen Free and Lead Free, L: Lead Free
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MARKING



■ PIN CONFIGURATION



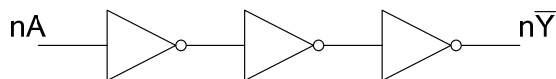
Note: The N.C is stand for that the pin is not connected.

■ FUNCTION TABLE

INPUT(nA)	OUTPUT(nY-bar)
L	H
H	L

Note: H: HIGH voltage level; L: LOW voltage level

■ LOGIC DIAGRAM (positive logic)



■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{CC}	-0.5 ~ +7.0	V
Input Voltage	V_{IN}	-0.5 ~ +16	V
V_{CC} or GND Current	I_{CC}	±50	mA
Continuous Output Current ($V_{OUT}=0$ to V_{CC})	I_{OUT}	±25	mA
Input Clamp Current ($V_{IN}<-0.5$)	I_{IK}	-20	mA
Output Clamp Current ($V_{OUT}<-0.5$ or $V_{OUT}> V_{CC}+0.5$)	I_{OK}	±20	mA
Storage Temperature Range	T_{STG}	-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}	Operating	2.0	5.0	6.0	V
Input Voltage	V_{IN}		0		15	V
Output Voltage	V_{OUT}	High or low state	0		V_{CC}	V
Operating Temperature	T_A		-40	+25	125	°C
Input Transition Rise or Fall Rate	$\Delta t/\Delta v$	$V_{CC}=2.0V$			1000	ns/V
		$V_{CC}=4.5V$			500	ns/V
		$V_{CC}=6.0V$			400	ns/V

■ ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-level Input Voltage	V_{IH}	$V_{CC}=2.0V$	1.5	1.3		V
		$V_{CC}=4.5V$	3.15	2.4		V
		$V_{CC}=6.0V$	4.2	3.1		V
Low-level Input Voltage	V_{IL}	$V_{CC}=2.0V$		0.7	0.5	V
		$V_{CC}=4.5V$		1.8	1.35	V
		$V_{CC}=6.0V$		2.3	1.8	V
High-Level Output Voltage	V_{OH}	$V_{CC}=2.0V, I_{OL}=-20\mu A$	1.9	2.0		V
		$V_{CC}=4.5V, I_{OL}=-20\mu A$	4.4	4.5		V
		$V_{CC}=6.0V, I_{OL}=-20\mu A$	5.9	6.0		V
		$V_{CC}=4.5V, I_{OL}=-4.0mA$	3.98			V
		$V_{CC}=6.0V, I_{OL}=-5.2mA$	5.48			V
Low-Level Output Voltage	V_{OL}	$V_{CC}=2.0V, I_{OL}=20\mu A$			0.1	V
		$V_{CC}=4.5V, I_{OL}=20\mu A$			0.1	V
		$V_{CC}=6.0V, I_{OL}=20\mu A$			0.1	V
		$V_{CC}=4.5V, I_{OL}=4.0mA$			0.26	V
		$V_{CC}=6.0V, I_{OL}=5.2mA$			0.26	V
Input Leakage Current	$I_{I(LEAK)}$	$V_{CC}=6.0V, V_{IN}=V_{CC}$ or GND			±0.1	μA
		$V_{CC}=6.0V, V_{IN}=15V$			±0.5	μA
Quiescent Supply Current	I_{CC}	$V_{CC}=6.0V, V_{IN}=15V$ or GND, $I_{OUT}=0$			2.0	μA
Input Capacitance	C_I			3.5		pF

■ SWITCHING CHARACTERISTICS ($T_A=25^\circ\text{C}$, Input $t_R/t_F=6\text{ns}$)

See Fig. 1 and Fig. 2 for test circuit and waveforms.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from input (nA) to output($n\bar{Y}$)	t_{PD}	$V_{CC}=2.0\text{V}$, $C_L=50\text{pF}$		28	85	ns
		$V_{CC}=4.5\text{V}$, $C_L=50\text{pF}$		10	17	ns
		$V_{CC}=5.0\text{V}$, $C_L=15\text{pF}$		8		ns
		$V_{CC}=6.0\text{V}$, $C_L=50\text{pF}$		8	14	ns
Output transition time ($n\bar{Y}$)	t_t	$V_{CC}=2.0\text{V}$, $C_L=50\text{pF}$		19	75	ns
		$V_{CC}=4.5\text{V}$, $C_L=50\text{pF}$		7	15	ns
		$V_{CC}=6.0\text{V}$, $C_L=50\text{pF}$		6	13	ns

■ OPERATING CHARACTERISTICS ($T_A=25^\circ\text{C}$)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	$V_{IN}=\text{GND to } V_{CC}$, $f=1\text{MHz}$, $C_L=50\text{pF}$		14		pF

■ TEST CIRCUIT AND WAVEFORMS

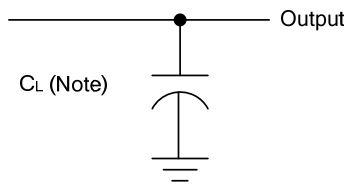


Fig. 1 Load circuitry for switching times

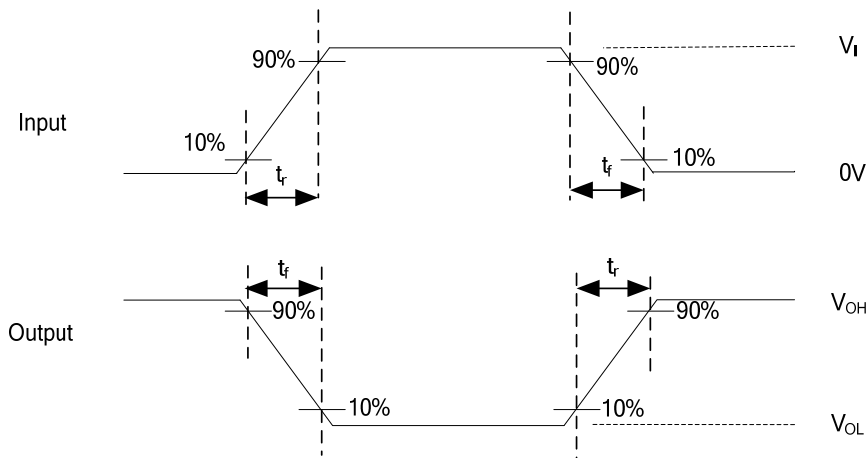
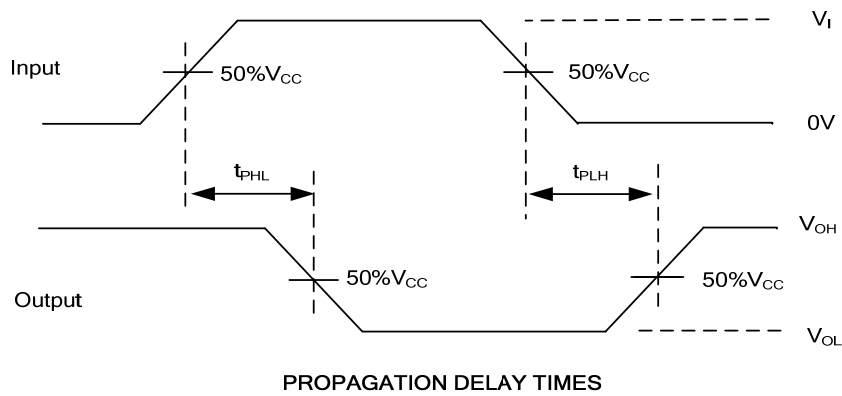


Fig. 2 Propagation delay from input(nA) to output(n \bar{Y}) and Output transition time

Note: C_L includes probe and jig capacitance.

All input pulses are supplied by generators having the following characteristics: PRR \leq 10MHz, $Z_O = 50\Omega$.

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